

<b>Notice of References Cited</b>	Application/Control No. 09/175,156		Applicant(s)/Patent Under Reexamination PUTNAM ET AL.	
	Examiner JOSEPH T. PHAN		Art Unit 2614	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,459,785 B1	10-2002	Naumburger, Volkmar	379/214.01
*	B	US-6,504,912 B1	01-2003	Glossbrenner, Kenneth C.	379/88.01
*	C	US-6,766,006 B1	07-2004	Hu et al.	379/201.12
*	D	US-6,961,559 B1	11-2005	Chow et al.	455/414.1
*	E	US-7,023,979 B1	04-2006	Wu et al.	379/265.11
*	F	US-7,280,649 B2	10-2007	Hu et al.	379/201.12
*	G	US-7,571,458 B1	08-2009	Eyal, Bartfeld	725/137
*	H	US-7,676,034 B1	03-2010	Wu et al.	379/265.01
*	I	US-7,916,858 B1	03-2011	Heller et al.	379/265.12
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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